Se	arch	ch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/667,658	PARK ET AL.
Examiner	Art Unit

Leila Malek

2611

SEARCHED			
Class	Subclass	Date	Examiner
375	233	2/1/2007	L.M
375	229	2/1/2007	L.M
326	. 93-96	2/1/2007	L.M
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST	2/1/2007	L.M
IEEE .	2/1/2007	L.M
GOOGLE	2/1/2007	L.M
Consulted M. Ghayour	10/23/2006	L.M
Consulted A. Tran	10/23/2006	L.M